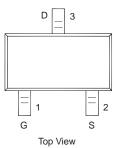
P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (mΩ) (Typ.)	I _D (A) ^a	Q _g (Typ.)			
- 30	34 at V _{GS} = - 10 V	- 6.2	10 nC			
- 30	43 at V _{GS} = - 4.5 V	- 5	10110			

SOT-23-3L



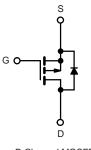
FEATURES

- DT-Trench Power MOSFET
- 100 % $\rm R_g$ and UIS Tested



APPLICATIONS

- For Mobile Computing
 - Load Switch
 - Notebook Adaptor Switch
 - DC/DC Converter



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 30	V	
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		- 6.2		
Continuous Drain Current (T. -150 °C)	T _C = 70 °C	I _D	- 5.3		
Continuous Drain Current ($T_J = 150 \text{ °C}$)	T _A = 25 °C		- 3.5 ^{b,c}		
	T _A = 70 °C		- 2.2 ^{b,c}	A	
Pulsed Drain Current (t = 100 µs)		I _{DM}	- 25		
Continuus Source Drain Diado Current	T _C = 25 °C	1	- 6		
Continous Source-Drain Diode Current	T _A = 25 °C	I _S	- 3.5 ^{b,c}		
	T _C = 25 °C		2.6		
Maximum Power Dissipation	T _C = 70 °C	– P _D	1.7	w	
	T _A = 25 °C		1.25 ^{b,c}	vv	
	T _A = 70 °C		0.8 ^{b,c}	1	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS

Parameter		Typical	Maximum	Unit		
$t \le 5 s$	R _{thJA}	75	100	°C/W		
Steady State	R _{thJF}	40	50	C/ VV		
	t ≤ 5 s	Symbol t ≤ 5 s R _{thJA}	Symbol Typical t ≤ 5 s R _{thJA} 75 Steady State R 40	SymbolTypicalMaximum $t \le 5$ s R_{thJA} 75100Steady StateP4050		

Notes:

a. Based on T_C = 25 °C.
b. Surface mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under steady state conditions is 166 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	1						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	 JI_D = - 250 μA		- 19		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	iD = - 230 μA		4		mv/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$	- 1		- 2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zara Cata Valtaga Drain Current	I _{DSS}	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1		
Zero Gate Voltage Drain Current		V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 55 °C			- 5	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le$ - 5 V, V_{GS} = - 10 V	- 6			А	
		V _{GS} =- 10 V, I _D = - 5 A		34	42		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} =- 4.5 V, I _D = - 3 A		43	53	mΩ	
Forward Transconductance ^a	g _{fs}	V _{DS} = - 5 V, I _D = - 5 A		18		S	
Dynamic ^b			•				
Input Capacitance	C _{iss}			695			
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		90		pF	
Reverse Transfer Capacitance	C _{rss}			55			
Total Gate Charge	Qg			16	28		
Gate-Source Charge	Q _{gs}	V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 5 A		2.5		nC	
Gate-Drain Charge	Q _{gd}			5.8			
Gate Resistance	R _g	f = 1 MHz		8		Ω	
Turn-On Delay Time	t _{d(on)}			18			
Rise Time	t _r	V _{DD} = - 15 V, R _L = 3.5 Ω		9		ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -5 \text{ A}, \text{ V}_{\text{GEN}} = -10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		30			
Fall Time	t _f			8			
Turn-On Delay Time	t _{d(on)}			36			
Rise Time	t _r	V_{DD} = - 15 V, R _L = 3.5 Ω		15			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -3 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1\Omega$		45			
Fall Time	t _f			60			
Drain-Source Body Diode Characteristic	cs		•				
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 6.2	А	
Pulse Diode Forward Current (t = $100 \ \mu s$)	I _{SM}				- 25	A	
Body Diode Voltage	V _{SD}	I _S = - 5 A, V _{GS} = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			18	25	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	$L_{-} = 5 \wedge dl/dt = 100 \wedge luo T = 25 \circ 0$		10	18	nC	
Reverse Recovery Fall Time	t _a	I _F = - 5 A, dl/dt = 100 A/μs, T _J = 25 °C		12			
Reverse Recovery Rise Time	t _b			15		ns	

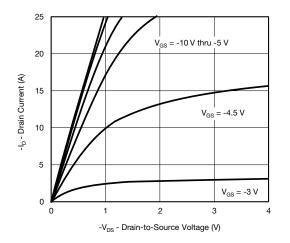
Notes:

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

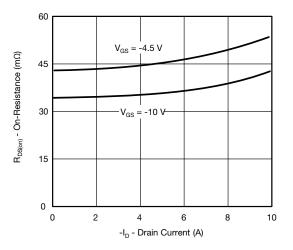
b. Guaranteed by design, not subject to production testing.

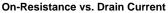
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

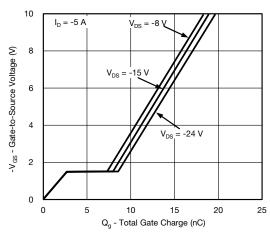




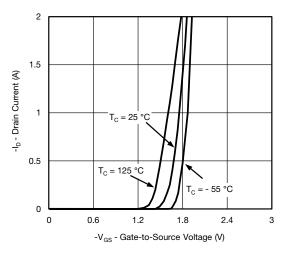




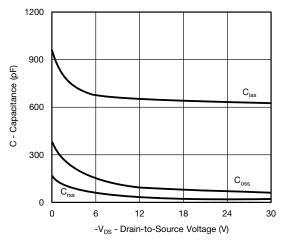




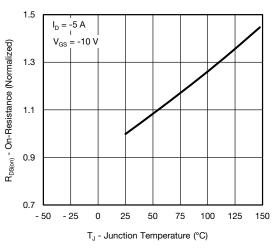
Gate Charge



Transfer Characteristics

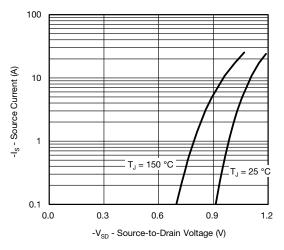




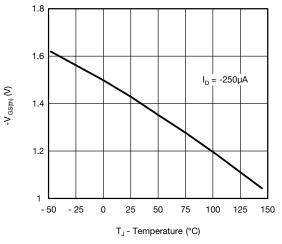


On-Resistance vs. Junction Temperature

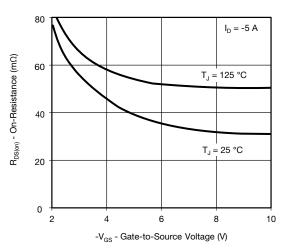




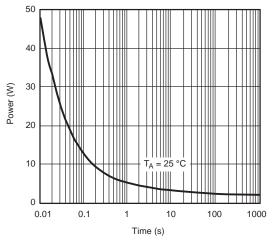
Source-Drain Diode Forward Voltage



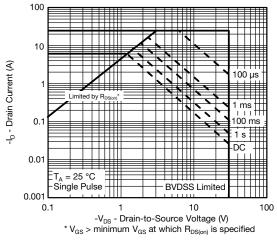
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

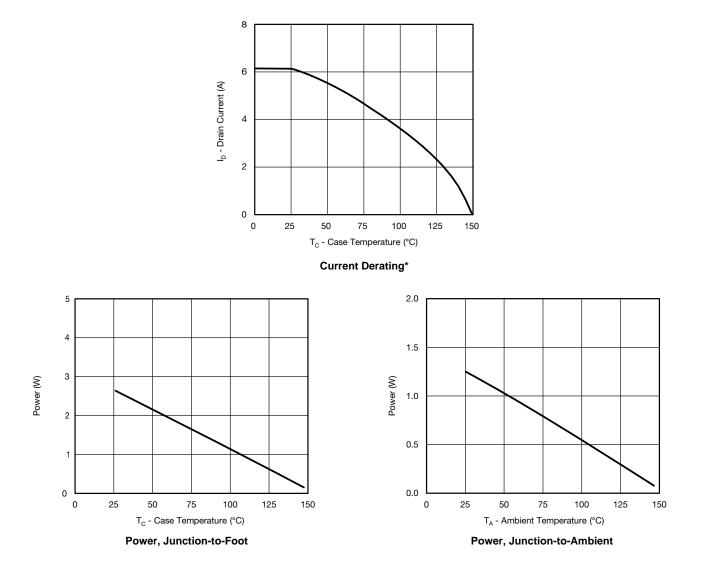


Single Pulse Power (Junction-to-Ambient)



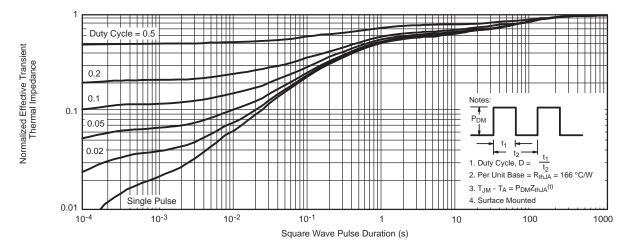
Safe Operating Area, Junction-to-Ambient



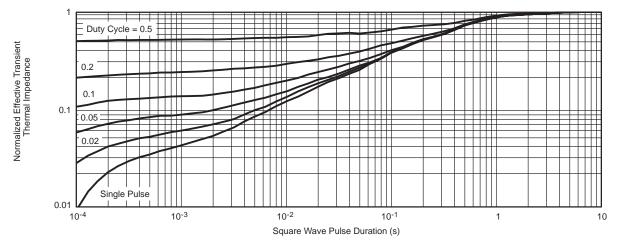


* The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



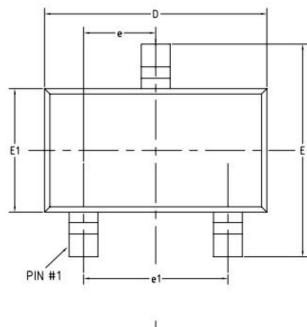


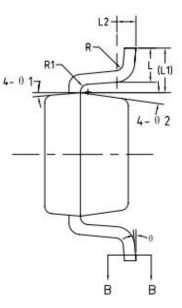
Normalized Thermal Transient Impedance, Junction-to-Ambient

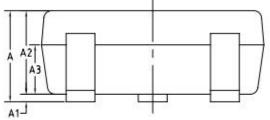


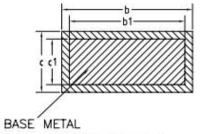
Normalized Thermal Transient Impedance, Junction-to-Foot

SOT-23-3L PACKAGE OUTLINE











COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX	
А	-	-	1.50	
A1	0.00	-	0.18	
A2	0.85	1.10	1.35	
A3	0.58	0.65	0.72	
b	0.23	-	0.53	
b1	0.20	0.40	0.50	
с	0.09	-	0.22	
c1	0.08	0.13	0.21	
D	2.78	2.95	3.10	
E	2.58	2.80	3.03	
E1	1.55	1.65	1.78	
е	0.83	0.95	1.07	
e1	1.78	1.90	2.02	
L	0.28	0.45	0.62	
L1	0.59REF			
L2	0.25BSC			
R	0.04	-	-	
R1	0.04	-	0.21	
θ	0°	-	8°	
θ1	8°	10°	12°	
θ2	8°	10°	12°	



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